S arch Notes

Applicati n/Contr I N .	Applicant(s)/Patent under R xamination
09/831,491	NGAIR, TEOW HIN
Examiner	Art Unit
Ali S. Abyaneh	2133

	SEARCHED				
Class	Subclass	Date	Examiner		
713	175	1/5/2005	AA		
380	21	12/27/2004	AA		
713	171	12/30/2005	AA		
E713	186	12/20/2004	AA		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	12/16/2004	AA		
NPL(INSPEC)	12/20/2004	AA		